

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

Advanced Measurement Machines, Inc.

8900 Eton Ave., Suite F, Canoga Park, CA 91304

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Calibration of Metrology Machines (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084 Initial Accreditation Date: January 20, 2017 Acc Issue Date: June 13, 2022 ation No:

Expiration Date: August 31, 2024

Accreditation No: 93108

Certificate No: L22-437

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.co



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Certificate of Accreditation: Supplement

Advanced Measurement Machines, Inc.

8900 Eton Ave., Suite F, Canoga Park, CA 91304 Contact Name: Bipin Mukherji Phone: 818-833-7777

Accreditation is granted to the facility to perform the following calibrations:

Dimensional			
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
CMM –	0.000 3 in to 24 in	$(71 + 3.3L) \mu in$	Step Gage
Linear Displacement ^{FO}			Procedure 200
CMM –			Step Gage / Sphere
Volumetric Accuracy ^{FO}			Procedure 200
CMM – Repeatability ^{FO}	25.4 mm	1.9 μm	Sphere
			Procedure 200
Optical Comparator –	0.001 in to 12 in	$(100 + 3.5L) \mu in$	Gage Blocks,
Squareness: Horizontal			Glass Grid
Displacement Y Axis			Procedure 100
Travel ^{FO}			Procedure 300
Optical Comparator –	6 in to 24 in		
Linearity X & Y ^{FO}			
Optical Comparator –	10X, 20X, 25X, 30X	0.02 % of Magnification	
Magnification ^{FO}	31.25X, 50X, 62.5X	0.04 % of Magnification	
Vision Measurement System	6 in to 100 in	$(32 + 3.5L) \mu in$	
– Linearity X & Y ^{FO}			
Vision Measurement System	6 in to 16 in		
– Linearity Z ^{FO}			

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer^{FO} would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.



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Accreditation is granted to the facility to perform the following calibrations:

- 4. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.
- 5. The term L represents length in inches or millimeters as appropriate to the uncertainty statement.
- 6. The term "X" proceeded by a number represents the number of times a lens system magnifies an image relative to its actual size. CMC stated as "% of magnification" represents the CMC of magnification expressed as a percentage of the total magnification.

